

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. 10/671,229
Confirmation No. 8204
Filing Date September 24, 2003
Inventor Leonard Forbes
Assignee Micron Technology, Inc.
Group Art Unit 2814
Examiner P. Long
Attorney's Docket No. MI22-2272
Customer No. 021567
Title: Dielectric Material Forming Methods and Enhanced Dielectric Methods

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References -See Attached Form PTO-1449

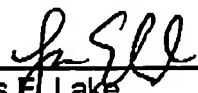
The Examiner's attention is directed to the reference which is listed on the attached Form PTO-1449, of which a copy is attached. No admission is made regarding whether the submitted reference is prior art.

Citation of the referenced art is respectfully requested.

This Supplemental Information Disclosure Statement is being filed within three months of the filing date of the application or before the mailing date of a first Office Action on the merits, whichever occurs last. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925.

Respectfully submitted,

Dated: 20 Dec 2004

By: 
James E. Lake
Reg. No. 44,854

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-3272		SERIAL NO. 10/671,229	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Leonard Forbes			
				FILING DATE September 24, 2003		GROUP 2811	
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	10/443,325		Forbes (as amended 11/1/2004)			05/21/2003
	AB						
	AC						
	AD						
	AE						
	AF						
	AO						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
	AH						
	AI						
	AJ						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AK						
	AL						
	AM						
	AN						
	AO						
EXAMINER				DATE CONSIDERED			
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							